

Search Notes

Application/Control No.

10/730,638

Examiner

Cam N. Nguyen

Applicant(s)/Patent under
Reexamination

TAKEISHI ET AL.

Art Unit

1754

SEARCHED

Class	Subclass	Date	Examiner
502	324 327	12/4/05	can
	329		
	331, 336		
502	336, 342 346		
11	11	5/30/06	can

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
west	12/4/05	can
Inventor name searched	12/4/05	can
above updated		can